

**Notice of References Cited**

Application/Control No.

10/572,515

Applicant(s)/Patent Under  
Reexamination  
HOYANO ET AL.

Examiner

BONG-SOOK BAEK

Art Unit

4161

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,541,488 b1	04-2003	Bernat et al.	514/327
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO/2002/028827	11-2002	PCT	Okazaki et al.	
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	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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